











#### SN54LVC573A, SN74LVC573A

SCAS300S - JANUARY 1993-REVISED MAY 2014

# SNx4LVC573A Octal Transparent D-Type Latches With 3-State Outputs

#### **Features**

- Operate From 1.65 V to 3.6 V
- Inputs Accept Voltages to 5.5 V
- Max t<sub>od</sub> of 6.9 ns at 3.3 V
- Typical V<sub>OLP</sub> (Output Ground Bounce)  $< 0.8 \text{ V at V}_{CC} = 3.3 \text{ V}, T_A = 25^{\circ}\text{C}$
- Typical V<sub>OHV</sub> (Output V<sub>OH</sub> Undershoot)  $> 2 \text{ V at V}_{CC} = 3.3 \text{ V}, T_A = 25^{\circ}\text{C}$
- Support Mixed-Mode Signal Operation on All Ports (5-V Input/Output Voltage With 3.3-V V<sub>CC</sub>)
- Ioff Supports Live Insertion, Partial Power Down Mode, and Back Drive Protection
- Latch-Up Performance Exceeds 250 mA Per JESD 17
- ESD Protection Exceeds JESD 22
  - 2000-V Human-Body Model (A114-A)
  - 200-V Machine Model (A115-A)
  - 1000-V Charged-Device Model (C101)

# **Applications**

- Servers
- PC, Notebook
- Network Switch
- Health & Fitness/Wearables
- Telecom Infrastructure
- Electronic Point of Sales

# 3 Description

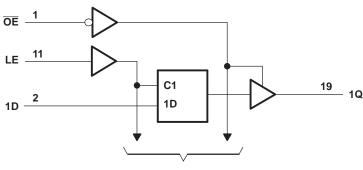
The SN54LVC573A octal transparent D-type latch is designed for 2.7-V to 3.6-V V<sub>CC</sub> operation, and the SN74LVC573A octal transparent D-type latch is designed for 1.65-V to 3.6-V  $V_{\text{CC}}$  operation. These devices feature 3-state outputs designed specifically for driving highly capacitive or relatively lowimpedance loads. They are particularly suitable for implementing buffer registers, input/output (I/O) ports, bidirectional bus drivers, and working registers.

#### Device Information<sup>(1)</sup>

PART NUMBER	PACKAGE	BODY SIZE (NOM)
	PDIP (20)	25.40 x 6.35 mm
	VQGN (20)	4.50 x 3.50 mm
SN74LVC573A	SOIC (20)	12.80 x 7.50 mm
	SSOP (20)	7.20 x 5.30 mm
	TVSOP (20)	5.00 x 4.40 mm

<sup>(1)</sup> For all available packages, see the orderable addendum at the end of the datasheet.

# Simplified Schematic



To Seven Other Channels

Pin numbers shown are for the DB, DGV, DW, FK, J, N, NS, PW, RGY, and W packages.



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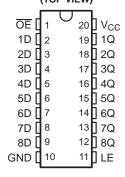
# 5 Revision History

Cr	nanges from Revision R (September 2005) to Revision S	Page
•	Removed Ordering Information table.	
•	Updated device temperature ratings.	4
•	Added Handling Ratings.	4
	Added Typical Characteristics.	
•	Added Detailed Description section.	
•	Added Applications and Implemetation section.	10
•	Added Power Supply Recommendations section	1
•	Added Layout section.	1

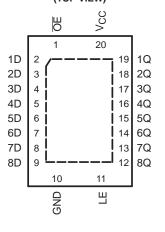


# 6 Pin Configuration and Functions

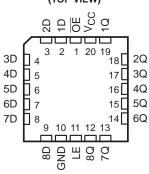
SN54LVC573A...J OR W PACKAGE SN74LVC573A...DB, DGV, DW, N, NS, OR PW PACKAGE (TOP VIEW)



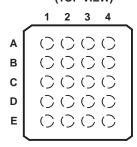
SN74LVC573A . . . RGY PACKAGE (TOP VIEW)



SN54LVC573A...FK PACKAGE (TOP VIEW)



GQN OR ZQN PACKAGE (TOP VIEW)



#### **Pin Functions**

	P	riN	T III T GIICTIONS	
	SN54LVC573A	SN74LVC573A		DESCRIPTION
NAME	J, W, AND FK	DB, DGV, DW, N, NS, PW, AND RGY	GQN AND ZQN	DESCRIPTION
ŌĒ	1	1	A2	Enable Pin
1D	2	2	A1	Input 1
2D	3	3	B3	Input 2
3D	4	4	B1	Input 3
4D	5	5	C2	Input 4
5D	6	6	C1	Input 5
6D	7	7	D3	Input 6
7D	8	8	D1	Input 7
8D	9	9	E2	Input 8
GND	10	10	E1	Ground Pin
LE	11	11	E3	Latch Enable
8Q	12	12	E4	Output 8
7Q	13	13	D2	Output 7
6Q	14	14	D4	Output 6
5Q	15	15	C3	Output 5
4Q	16	16	C4	Output 4
3Q	17	17	B2	Output 3
2Q	18	18	B4	Output 2
1Q	19	19	A4	Output 1
V <sub>CC</sub>	20	20	A3	Power Pin

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# 7 Specifications

# 7.1 Absolute Maximum Ratings<sup>(1)</sup>

over operating free-air temperature range (unless otherwise noted)

			MIN	MAX	UNIT
V <sub>CC</sub>	Supply voltage		-0.5	6.5	V
VI	Input voltage range (2)		-0.5	6.5	V
Vo	Voltage range applied to any output in the high-impe	edance or power-off state (2)	-0.5	6.5	V
Vo	Voltage range applied to any output in the high or lo	ow state (2)(3)	-0.5	V <sub>CC</sub> + 0.5	V
I <sub>IK</sub>	Input clamp current	V <sub>1</sub> < 0		<b>-</b> 50	mA
I <sub>OK</sub>	Output clamp current	V <sub>O</sub> < 0		<b>-</b> 50	mA
Io	Continuous output current			±50	mA
	Continuous current through V <sub>CC</sub> or GND			±100	mA
		DB package (4)		70	
		DGV package <sup>(4)</sup>	92		  -
		DW package <sup>(4)</sup>		58	
0	Desires the word increased	GQN or ZQN package <sup>(4)</sup>		78	00/14/
$\theta_{JA}$	Package thermal impedance	N package <sup>(4)</sup>	69		°C/W
		NS package (4)	60		ļ
		PW package <sup>(4)</sup>		83	
		RGY package <sup>(5)</sup>		37	

<sup>(1)</sup> Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

- (2) The input and output negative-voltage ratings may be exceeded if the input and output current ratings are observed.
- (3) The value of V<sub>CC</sub> is provided in the recommended operating conditions table.
- (4) The package thermal impedance is calculated in accordance with JESD 51-7.
- (5) The package thermal impedance is calculated in accordance with JESD 51-5.

#### 7.2 Handling Ratings

			MIN	MAX	UNIT
T <sub>stg</sub>	Storage temperature range		-65	150	°C
	Human body model (HBM), per ANSI/ESDA/JEDEC JS-001, all pins <sup>(1)</sup>	0	2000	V	
V <sub>(ESD)</sub>	Electrostatic discharge	Charged device model (CDM), per JEDEC specification JESD22-C101, all pins (2)	0	1000	V

<sup>(1)</sup> JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process. Pins listed as 500 V may actually have higher performance.

<sup>(2)</sup> JEDEC document JEP157 states that 250-V CDM allows safe manufacturing with a standard ESD control process. Pins listed as 250 V may actually have higher performance.



# 7.3 Recommended Operating Conditions<sup>(1)</sup>

			SN54LVC573A		SN74L\	/C573A	LIAUT
			MIN	MAX	MIN	MAX	UNIT
V	Cupalicualitana	Operating	2	3.6	1.65	3.6	V
$V_{CC}$	Supply voltage	Data retention only	1.5		1.5		V
		V <sub>CC</sub> = 1.65 V to 1.95 V			0.65 × V <sub>CC</sub>		
$V_{IH}$	High-level input voltage	V <sub>CC</sub> = 2.3 V to 2.7 V			1.7		V
		$V_{CC} = 2.7 \text{ V to } 3.6 \text{ V}$	2		2		
		$V_{CC} = 1.65 \text{ V to } 1.95 \text{ V}$				$0.35 \times V_{CC}$	
V <sub>IL</sub> Lov	Low-level input voltage	$V_{CC} = 2.3 \text{ V to } 2.7 \text{ V}$				0.7	V
		$V_{CC} = 2.7 \text{ V to } 3.6 \text{ V}$		0.8		0.8	
VI	Input voltage		0	5.5	0	5.5	V
	Outrot wells as	High or low state	0	$V_{CC}$	0	$V_{CC}$	V
$V_O$	Output voltage	3-state	0	5.5	0	5.5	V
		V <sub>CC</sub> = 1.65 V				-4	
	High level output ourrent	$V_{CC} = 2.3 \text{ V}$				8	mA
I <sub>OH</sub>	High-level output current	$V_{CC} = 2.7 \text{ V}$		-12		-12	mA
		$V_{CC} = 3 V$		-24		-24	
		$V_{CC} = 1.65 \text{ V}$				4	
	Low lovel output ourrent	$V_{CC} = 2.3 \text{ V}$				8	A
I <sub>OL</sub>	Low-level output current	$V_{CC} = 2.7 \text{ V}$		12		12	mA
		V <sub>CC</sub> = 3 V		24		24	
Δt/Δν	Input transition rise or fall rate			6		6	ns/V
T <sub>A</sub>	Operating free-air temperature		-55	125	-40	85	°C

<sup>(1)</sup> All unused inputs of the device must be held at V<sub>CC</sub> or GND to ensure proper device operation. Refer to the TI application report, Implications of Slow or Floating CMOS Inputs, literature number SCBA004.

# 7.4 Thermal Information

	THERMAL METRIC <sup>(1)</sup>	PW	UNIT
		20 PINS	
$R_{\theta JA}$	Junction-to-ambient thermal resistance	102.5	
$R_{\theta JCtop}$	Junction-to-case (top) thermal resistance	35.9	
$R_{\theta JB}$	Junction-to-board thermal resistance	53.5	°C/W
$\Psi_{JT}$	Junction-to-top characterization parameter	2.2	
ΨЈВ	Junction-to-board characterization parameter	52.9	

(1) For more information about traditional and new thermal metrics, see the IC Package Thermal Metrics application report, SPRA953.



# 7.5 Electrical Characteristics

over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST COMPLETIONS		SN54L	VC573A	SN74	ILVC573A		LINUT
PANAMETER	TEST CONDITIONS	V <sub>cc</sub>	MIN 7	TYP <sup>(1)</sup> MAX	MIN	TYP <sup>(1)</sup>	MAX	UNIT
	1004	1.65 V to 3.6 V			$V_{CC} - 0.2$			
	$I_{OH} = -100 \mu A$	2.7 V to 3.6 V	V <sub>CC</sub> - 0.2					
	I <sub>OH</sub> = -4 mA	1.65 V			1.2			
$V_{OH}$	$I_{OH} = -8 \text{ mA}$	2.3 V			1.7			V
	10 m/s	2.7 V	2.2		2.2			
	$I_{OH} = -12 \text{ mA}$	3 V	2.4		2.4			
	$I_{OH} = -24 \text{ mA}$	3 V	2.2		2.2			
	1004	1.65 V to 3.6 V					0.2	
	$I_{OL} = 100 \mu\text{A}$	2.7 V to 3.6 V		0.2				V
W	I <sub>OL</sub> = 4 mA	1.65 V					0.45	
$V_{OL}$	I <sub>OL</sub> = 8 mA	2.3 V					0.7	V
	I <sub>OL</sub> = 12 mA	2.7 V		0.4			0.4	
	I <sub>OL</sub> = 24 mA	3 V		0.55			0.55	
I <sub>I</sub>	V <sub>I</sub> = 0 to 5.5 V	3.6 V		±5			±5	μΑ
I <sub>off</sub>	$V_I$ or $V_O = 5.5 \text{ V}$	0					±10	μΑ
l <sub>OZ</sub>	V <sub>O</sub> = 0 to 5.5 V	3.6 V		±15			±10	μΑ
	V <sub>I</sub> = V <sub>CC</sub> or GND	2.21/		10			10	
I <sub>CC</sub>	$3.6 \text{ V} \le \text{V}_1 \le 5.5 \text{ V}^{(2)}$ $I_0 = 0$	3.6 V	10		10		10	μA
ΔI <sub>CC</sub>	One input at V <sub>CC</sub> – 0.6 V, Other inputs at V <sub>CC</sub> or GND	2.7 V to 3.6 V		500			500	μΑ
Ci	V <sub>I</sub> = V <sub>CC</sub> or GND	3.3 V		4		4		pF
Co	V <sub>O</sub> = V <sub>CC</sub> or GND	3.3 V		5.5		5.5		pF

<sup>(1)</sup> All typical values are at  $V_{CC}$  = 3.3 V,  $T_A$  = 25°C. (2) This applies in the disabled state only.

# 7.6 Timing Requirements, SN54LVC573A

over recommended operating free-air temperature range (unless otherwise noted) (see Figure 3)

		SN54LVC573A				
		V <sub>CC</sub> = 2.7 V		V <sub>CC</sub> = 3.3 V ± 0.3 V		UNIT
		MIN	MAX	MIN	MAX	
t <sub>w</sub>	Pulse duration, LE high	3.3		3.3		ns
t <sub>su</sub>	Setup time, data before LE↓	2		2		ns
t <sub>h</sub>	Hold time, data after LE↓	2.5		2.5		ns

# 7.7 Timing Requirements, SN74LVC573A

over recommended operating free-air temperature range (unless otherwise noted) (see Figure 3)

			SN74LVC573A							
		V <sub>CC</sub> = ± 0.1	1.8 V 5 V	V <sub>CC</sub> = ± 0.2	2.5 V 2 V	V <sub>CC</sub> =	2.7 V	V <sub>CC</sub> = 3 ± 0.3	3.3 V 3 V	UNIT
		MIN	MAX	MIN	MAX	MIN	MAX	MIN	MAX	
t <sub>w</sub>	Pulse duration, LE high	9		4		3.3		3.3		ns
t <sub>su</sub>	Setup time, data before LE↓	6		4		2		2		ns
t <sub>h</sub>	Hold time, data after LE↓	4		2		1.5		1.5		ns

Product Folder Links: SN54LVC573A SN74LVC573A



# 7.8 Switching Characteristics, SN54LVC573A

over recommended operating free-air temperature range (unless otherwise noted) (see Figure 3)

			SN54LV	C573A		
PARAMETER	FROM (INPUT)	TO (OUTPUT)	V <sub>CC</sub> = 2.7 V	V <sub>CC</sub> = 3 ± 0.3	V 8.5	UNIT
			MIN MAX	MIN	MAX	
	D	0	7.7	1	6.9	
t <sub>pd</sub>	LE	Q	8.4	1	7.7	ns
t <sub>en</sub>	ŌĒ	Q	8.5	1	7.5	ns
t <sub>dis</sub>	ŌĒ	Q	7	0.5	6.7	ns

# 7.9 Switching Characteristics, SN74LVC573A

over recommended operating free-air temperature range (unless otherwise noted) (see Figure 3)

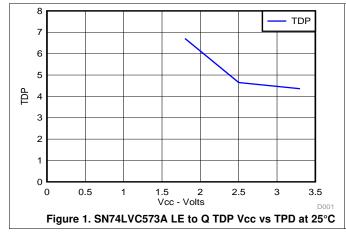
			SN74LVC573A								
PARAMETER	FROM (INPUT)	TO (OUTPUT)	V <sub>CC</sub> = 1.8 V ± 0.15 V		V <sub>CC</sub> = 2.5 V ± 0.2 V		V <sub>CC</sub> = 2.7 V		V <sub>CC</sub> = 3.3 V ± 0.3 V		UNIT
			MIN	MAX	MIN	MAX	MIN	MAX	MIN	MAX	
	D	0	1	19.1	1	9.6	1	7.7	1.5	6.9	ns
t <sub>pd</sub>	LE	Q	1	22.8	1	10.5	1	8.4	2	7.7	
t <sub>en</sub>	ŌĒ	Q	1	20	1	10.5	1	8.5	1.5	7.5	ns
t <sub>dis</sub>	ŌĒ	Q	1	19.3	1	7.8	1	7	1.6	6.5	ns
t <sub>sk(o)</sub>										1	ns

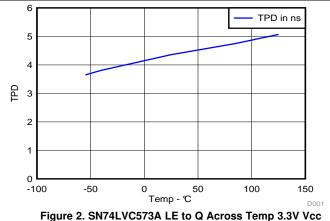
# 7.10 Operating Characteristics

 $T_A = 25^{\circ}C$ 

	PARAMETER		TEST CONDITIONS	V <sub>CC</sub> = 1.8 V TYP	V <sub>CC</sub> = 2.5 V TYP	V <sub>CC</sub> = 3.3 V TYP	UNIT
Power dissipation		Outputs enabled	f = 10 MHz	61	56	37	~F
Opd	C <sub>pd</sub> capacitance per latch	Outputs disabled	I = IU IVINZ	3	3	4	рF

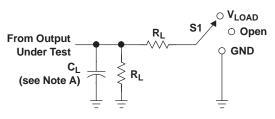
# 7.11 Typical Characteristics







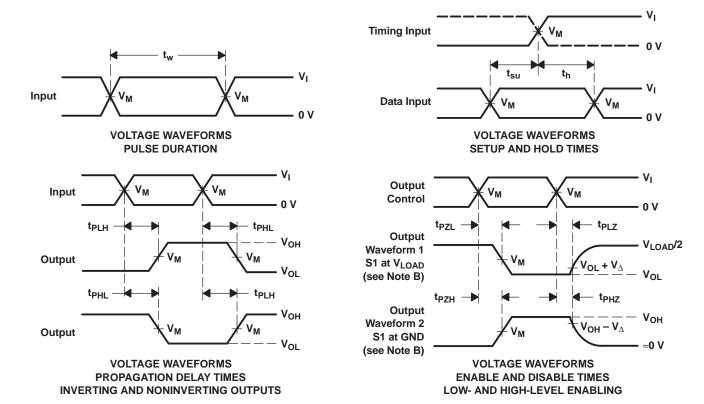
#### 8 Parameter Measurement Information



TEST	S1
t <sub>PLH</sub> /t <sub>PHL</sub>	Open
t <sub>PLZ</sub> /t <sub>PZL</sub>	V <sub>LOAD</sub>
t <sub>PHZ</sub> /t <sub>PZH</sub>	GND

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L	JAU	CIR	Ŀι	IJІ

.,	INF	PUTS	.,	.,			.,
V <sub>CC</sub>	$V_{I}$	t <sub>r</sub> /t <sub>f</sub>	V <sub>M</sub>	V <sub>LOAD</sub>	CL	R <sub>L</sub>	$oldsymbol{V}_\Delta$
1.8 V $\pm$ 0.15 V	V <sub>CC</sub>	≤2 ns	V <sub>CC</sub> /2	2×V <sub>CC</sub>	30 pF	<b>1 k</b> Ω	0.15 V
2.5 V $\pm$ 0.2 V	$V_{CC}$	≤2 ns	V <sub>CC</sub> /2	2×V <sub>CC</sub>	30 pF	500 Ω	0.15 V
2.7 V	2.7 V	≤2.5 ns	1.5 V	6 V	50 pF	500 Ω	0.3 V
3.3 V $\pm$ 0.3 V	2.7 V	≤2.5 ns	1.5 V	6 V	50 pF	500 Ω	0.3 V



NOTES: A.  $C_L$  includes probe and jig capacitance.

- B. Waveform 1 is for an output with internal conditions such that the output is low, except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high, except when disabled by the output control.
- C. All input pulses are supplied by generators having the following characteristics: PRR ≤ 10 MHz, Z<sub>O</sub> = 50 Ω.
- D. The outputs are measured one at a time, with one transition per measurement.
- E.  $t_{PLZ}$  and  $t_{PHZ}$  are the same as  $t_{dis}$ .
- F.  $t_{PZL}$  and  $t_{PZH}$  are the same as  $t_{en}$ .
- G.  $t_{PLH}$  and  $t_{PHL}$  are the same as  $t_{pd}$ .
- H. All parameters and waveforms are not applicable to all devices.

Figure 3. Load Circuit and Voltage Waveforms

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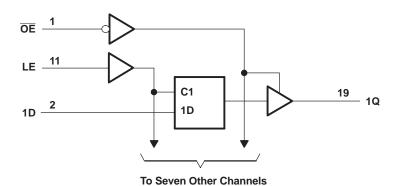


# 9 Detailed Description

#### 9.1 Overview

The SN54LVC573A octal transparent D-type latch is designed for 2.7-V to 3.6-V  $V_{CC}$  operation, and the SN74LVC573A octal transparent D-type latch is designed for 1.65-V to 3.6-V  $V_{CC}$  operation. These devices feature 3-state outputs designed specifically for driving highly capacitive or relatively low-impedance loads. They are particularly suitable for implementing buffer registers, input/output (I/O) ports, bidirectional bus drivers, and working registers. While the latch-enable (LE) input is high, the Q outputs follow the data (D) inputs. When LE is taken low, the Q outputs are latched at the logic levels at the D inputs. A buffered output-enable ( $\overline{OE}$ ) input can be used to place the eight outputs in either a normal logic state (high or low logic levels) or the high-impedance state. In the high-impedance state, the outputs neither load nor drive the bus lines significantly. The high-impedance state and increased drive provide the capability to drive bus lines without interface or pullup components.  $\overline{OE}$  does not affect the internal operations of the latches. Old data can be retained or new data can be entered while the outputs are in the high-impedance state. These devices are fully specified for partial-power-down applications using  $I_{off}$ . The  $I_{off}$  circuitry disables the outputs, preventing damaging current backflow through the device when it is powered down.

#### 9.2 Functional Block Diagram



Pin numbers shown are for the DB, DGV, DW, FK, J, N, NS, PW, RGY, and W packages.

#### 9.3 Feature Description

- · Wide operating voltage range
  - Operates from 1.65 V to 3.6 V
- Allows down voltage translation
  - Inputs accept voltages to 5.5 V
- I<sub>off</sub> Feature
  - Allows voltages on the inputs and outputs when V<sub>CC</sub> is 0 V

#### 9.4 Device Functional Modes

# Function Table (Each Latch)

	INPUTS		OUTPUT
ŌĒ	LE	D	Q
L	Н	Н	Н
L	Н	L	L
L	L	X	$Q_0$
Н	Χ	Χ	Z

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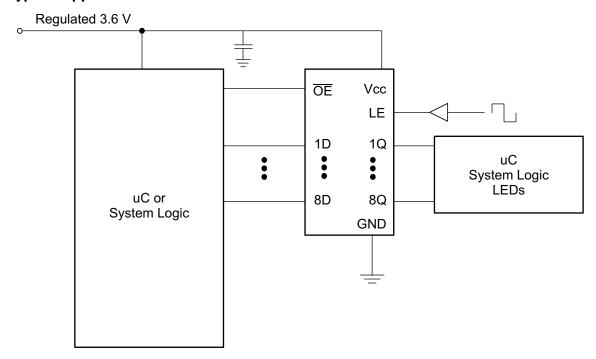


# 10 Applications and Implementation

#### 10.1 Application Information

The SN74LVC573A is a high drive CMOS device that can be used for a multitude of bus interface type applications where the data needs to be retained or latched . It can produce 24 mA of drive current at 3.3 V making it Ideal for driving multiple outputs and good for high speed applications up to 100 MHz. The inputs are 5.5 V tolerant allowing it to translate down to  $V_{\rm CC}$ .

# 10.2 Typical Application



#### 10.2.1 Design Requirements

This device uses CMOS technology and has balanced output drive. Care should be taken to avoid bus contention because it can drive currents that would exceed maximum limits. The high drive will also create fast edges into light loads so routing and load conditions should be considered to prevent ringing.

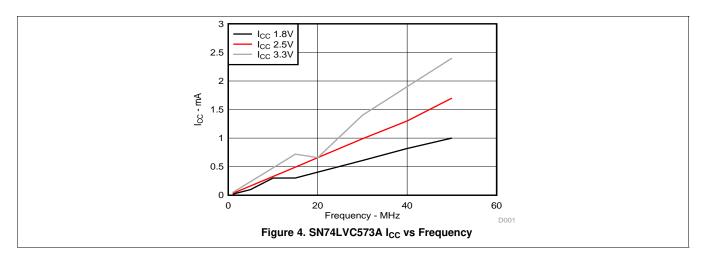
#### 10.2.2 Detailed Design Procedure

- 1. Recommended Input conditions
  - Rise time and fall time specifications. See (Δt/ΔV) in Recommended Operating Conditions table.
  - Specified high and low levels. See (V<sub>IH</sub> and V<sub>II</sub>) in Recommended Operating Conditions table.
  - Inputs are overvoltage tolerant allowing them to go as high as 5.5V at any valid  $V_{CC}$ .
- 2. Recommend output conditions
  - Load currents should not exceed 25 mA per output and 50 mA total for the part.
  - Outputs should not be pulled above V<sub>CC</sub>.



# Typical Application (continued)

#### 10.2.3 Application Curves



# 11 Power Supply Recommendations

The power supply can be any voltage between the Min and Max supply voltage rating located in the Recommended Operating Conditions table.

Each V<sub>CC</sub> pin should have a good bypass capacitor to prevent power disturbance. For devices with a single supply, a 0.1-µF capacitor is recommended. If there are multiple VCC pins, then a 0.01-µF or 0.022-µF capacitor is recommended for each power pin. It is ok to parallel multiple bypass capacitors to reject different frequencies of noise. A 0.1-µF and 1-µF capacitors are commonly used in parallel. The bypass capacitor should be installed as close to the power pin as possible for best results.

# 12 Layout

#### 12.1 Layout Guidelines

When using multiple bit logic devices inputs should not ever float. In many cases, functions or parts of functions of digital logic devices are unused, for example, when only two inputs of a triple-input AND gate are used or only 3 of the 4 buffer gates are used. Such input pins should not be left unconnected because the undefined voltages at the outside connections result in undefined operational states. Specified below are the rules that must be observed under all circumstances. All unused inputs of digital logic devices must be connected to a high or low bias to prevent them from floating. The logic level that should be applied to any particular unused input depends on the function of the device. Generally they will be tied to GND or V<sub>CC</sub> whichever make more sense or is more convenient. It is generally OK to float outputs unless the part is a transceiver. If the transceiver has an output enable pin it will disable the outputs section of the part when asserted. This will not disable the input section of the IOs so they also cannot float when disabled.

#### 12.2 Layout Example



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# 13 Device and Documentation Support

#### 13.1 Related Links

The table below lists quick access links. Categories include technical documents, support and community resources, tools and software, and quick access to sample or buy.

Table 1. Related Links

PARTS	PRODUCT FOLDER	SAMPLE & BUY	TECHNICAL DOCUMENTS	TOOLS & SOFTWARE	SUPPORT & COMMUNITY
SN54LVC573A	Click here	Click here	Click here	Click here	Click here
SN74LVC573A	Click here	Click here	Click here	Click here	Click here

# 13.2 Trademarks

All trademarks are the property of their respective owners.

# 13.3 Electrostatic Discharge Caution



These devices have limited built-in ESD protection. The leads should be shorted together or the device placed in conductive foam during storage or handling to prevent electrostatic damage to the MOS gates.

# 13.4 Glossary

SLYZ022 — TI Glossary.

This glossary lists and explains terms, acronyms and definitions.

# 14 Mechanical, Packaging, and Orderable Information

The following pages include mechanical packaging and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.



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# **PACKAGING INFORMATION**

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan	Lead finish/ Ball material	MSL Peak Temp	Op Temp (°C)	Device Marking (4/5)	Samples
5962-9757501Q2A	ACTIVE	LCCC	FK	20	1	Non-RoHS & Green	SNPB	N / A for Pkg Type	-55 to 125	5962- 9757501Q2A SNJ54LVC 573AFK	Samples
5962-9757501QRA	ACTIVE	CDIP	J	20	1	Non-RoHS & Green	SNPB	N / A for Pkg Type	-55 to 125	5962-9757501QR A SNJ54LVC573AJ	Samples
5962-9757501QSA	ACTIVE	CFP	W	20	1	Non-RoHS & Green	SNPB	N / A for Pkg Type	-55 to 125	5962-9757501QS A SNJ54LVC573AW	Samples
SN74LVC573ADBR	ACTIVE	SSOP	DB	20	2000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 125	LC573A	Samples
SN74LVC573ADGVR	ACTIVE	TVSOP	DGV	20	2000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 125	LC573A	Samples
SN74LVC573ADW	ACTIVE	SOIC	DW	20	25	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 125	LVC573A	Samples
SN74LVC573ADWR	ACTIVE	SOIC	DW	20	2000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 125	LVC573A	Samples
SN74LVC573ADWRG4	ACTIVE	SOIC	DW	20	2000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 125	LVC573A	Samples
SN74LVC573AN	ACTIVE	PDIP	N	20	20	RoHS & Non-Green	NIPDAU	N / A for Pkg Type	-40 to 125	SN74LVC573AN	Samples
SN74LVC573ANSR	ACTIVE	so	NS	20	2000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 125	LVC573A	Samples
SN74LVC573ANSRE4	ACTIVE	SO	NS	20	2000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 125	LVC573A	Samples
SN74LVC573APW	ACTIVE	TSSOP	PW	20	70	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 125	LC573A	Samples
SN74LVC573APWG4	ACTIVE	TSSOP	PW	20	70	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 125	LC573A	Samples
SN74LVC573APWR	ACTIVE	TSSOP	PW	20	2000	RoHS & Green	NIPDAU   SN	Level-1-260C-UNLIM	-40 to 125	LC573A	Samples
SN74LVC573APWRE4	ACTIVE	TSSOP	PW	20	2000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 125	LC573A	Samples
SN74LVC573APWRG4	ACTIVE	TSSOP	PW	20	2000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 125	LC573A	Samples
SN74LVC573APWT	ACTIVE	TSSOP	PW	20	250	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 125	LC573A	Samples

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Orderable Device	Status	Package Type	Package Drawing	Pins	Package Qty	Eco Plan	Lead finish/ Ball material	MSL Peak Temp	Op Temp (°C)	Device Marking (4/5)	Samples
	. ,					. ,	(6)	. ,		, ,	
SN74LVC573ARGYR	ACTIVE	VQFN	RGY	20	3000	RoHS & Green	NIPDAU	Level-2-260C-1 YEAR	-40 to 125	LC573A	Samples
SNJ54LVC573AFK	ACTIVE	LCCC	FK	20	1	Non-RoHS & Green	SNPB	N / A for Pkg Type	-55 to 125	5962- 9757501Q2A SNJ54LVC 573AFK	Samples
SNJ54LVC573AJ	ACTIVE	CDIP	J	20	1	Non-RoHS & Green	SNPB	N / A for Pkg Type	-55 to 125	5962-9757501QR A SNJ54LVC573AJ	Samples
SNJ54LVC573AW	ACTIVE	CFP	W	20	1	Non-RoHS & Green	SNPB	N / A for Pkg Type	-55 to 125	5962-9757501QS A SNJ54LVC573AW	Samples

<sup>(1)</sup> The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

(2) RoHS: TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

RoHS Exempt: TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

**Green:** TI defines "Green" to mean the content of Chlorine (Cl) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

- (3) MSL, Peak Temp. The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.
- (4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.
- (5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.
- (6) Lead finish/Ball material Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

# **PACKAGE OPTION ADDENDUM**

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**Important Information and Disclaimer:** The information provided on this page represents TI's knowledge and belief as of the date that it is provided. TI bases its knowledge and belief on information provided by third parties, and makes no representation or warranty as to the accuracy of such information. Efforts are underway to better integrate information from third parties. TI has taken and continues to take reasonable steps to provide representative and accurate information but may not have conducted destructive testing or chemical analysis on incoming materials and chemicals. TI and TI suppliers consider certain information to be proprietary, and thus CAS numbers and other limited information may not be available for release.

In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.

#### OTHER QUALIFIED VERSIONS OF SN54LVC573A, SN74LVC573A:

Catalog: SN74LVC573A

Automotive: SN74LVC573A-Q1, SN74LVC573A-Q1

Enhanced Product: SN74LVC573A-EP, SN74LVC573A-EP

Military: SN54LVC573A

NOTE: Qualified Version Definitions:

- Catalog TI's standard catalog product
- Automotive Q100 devices qualified for high-reliability automotive applications targeting zero defects
- Enhanced Product Supports Defense, Aerospace and Medical Applications
- Military QML certified for Military and Defense Applications



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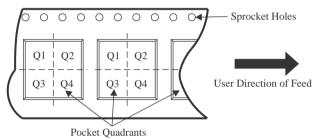
# TAPE AND REEL INFORMATION



# TAPE DIMENSIONS KO P1 BO W Cavity A0

A0	Dimension designed to accommodate the component width
В0	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

#### QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE

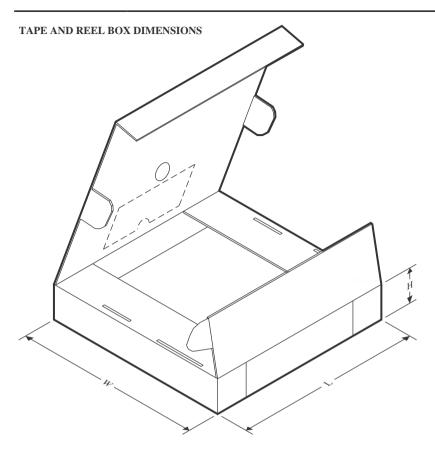


#### \*All dimensions are nominal

Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
SN74LVC573ADBR	SSOP	DB	20	2000	330.0	16.4	8.2	7.5	2.5	12.0	16.0	Q1
SN74LVC573ADGVR	TVSOP	DGV	20	2000	330.0	12.4	6.9	5.6	1.6	8.0	12.0	Q1
SN74LVC573ADWR	SOIC	DW	20	2000	330.0	24.4	10.9	13.3	2.7	12.0	24.0	Q1
SN74LVC573ANSR	so	NS	20	2000	330.0	24.4	8.4	13.0	2.5	12.0	24.0	Q1
SN74LVC573APWR	TSSOP	PW	20	2000	330.0	16.4	6.95	7.1	1.6	8.0	16.0	Q1
SN74LVC573APWR	TSSOP	PW	20	2000	330.0	16.4	6.95	7.0	1.4	8.0	16.0	Q1
SN74LVC573APWRG4	TSSOP	PW	20	2000	330.0	16.4	6.95	7.0	1.4	8.0	16.0	Q1
SN74LVC573APWT	TSSOP	PW	20	250	330.0	16.4	6.95	7.1	1.6	8.0	16.0	Q1
SN74LVC573ARGYR	VQFN	RGY	20	3000	330.0	12.4	3.8	4.8	1.6	8.0	12.0	Q1



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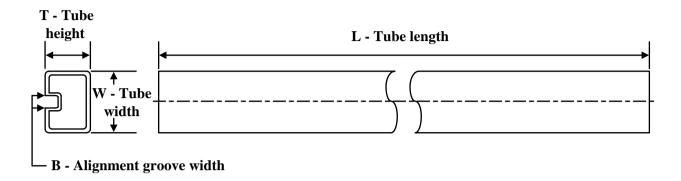
\*All dimensions are nominal

7 til dillionololio die nominal							
Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
SN74LVC573ADBR	SSOP	DB	20	2000	356.0	356.0	35.0
SN74LVC573ADGVR	TVSOP	DGV	20	2000	356.0	356.0	35.0
SN74LVC573ADWR	SOIC	DW	20	2000	367.0	367.0	45.0
SN74LVC573ANSR	SO	NS	20	2000	367.0	367.0	45.0
SN74LVC573APWR	TSSOP	PW	20	2000	364.0	364.0	27.0
SN74LVC573APWR	TSSOP	PW	20	2000	356.0	356.0	35.0
SN74LVC573APWRG4	TSSOP	PW	20	2000	356.0	356.0	35.0
SN74LVC573APWT	TSSOP	PW	20	250	356.0	356.0	35.0
SN74LVC573ARGYR	VQFN	RGY	20	3000	356.0	356.0	35.0

# **PACKAGE MATERIALS INFORMATION**

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# **TUBE**

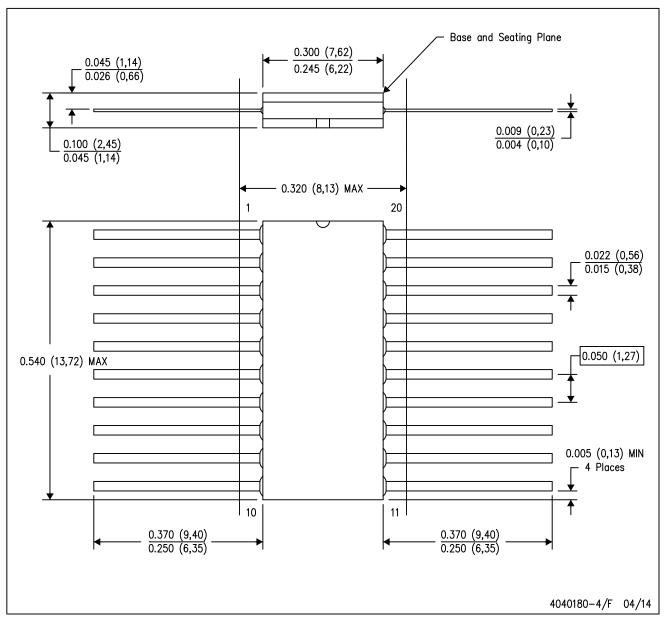


\*All dimensions are nominal

Device	Package Name	Package Type	Pins	SPQ	L (mm)	W (mm)	T (µm)	B (mm)
5962-9757501Q2A	FK	LCCC	20	1	506.98	12.06	2030	NA
5962-9757501QSA	W	CFP	20	1	506.98	26.16	6220	NA
SN74LVC573ADW	DW	SOIC	20	25	507	12.83	5080	6.6
SN74LVC573AN	N	PDIP	20	20	506	13.97	11230	4.32
SN74LVC573APW	PW	TSSOP	20	70	530	10.2	3600	3.5
SN74LVC573APWG4	PW	TSSOP	20	70	530	10.2	3600	3.5
SNJ54LVC573AFK	FK	LCCC	20	1	506.98	12.06	2030	NA
SNJ54LVC573AW	W	CFP	20	1	506.98	26.16	6220	NA

# W (R-GDFP-F20)

# CERAMIC DUAL FLATPACK



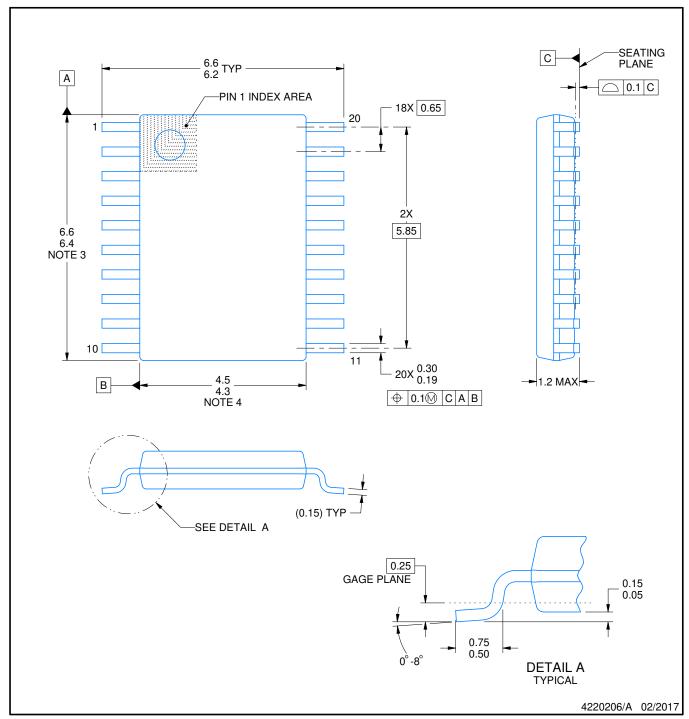
- A. All linear dimensions are in inches (millimeters).
- This drawing is subject to change without notice.
- C. This package can be hermetically sealed with a ceramic lid using glass frit.

  D. Index point is provided on cap for terminal identification only.

  E. Falls within Mil—Std 1835 GDFP2—F20





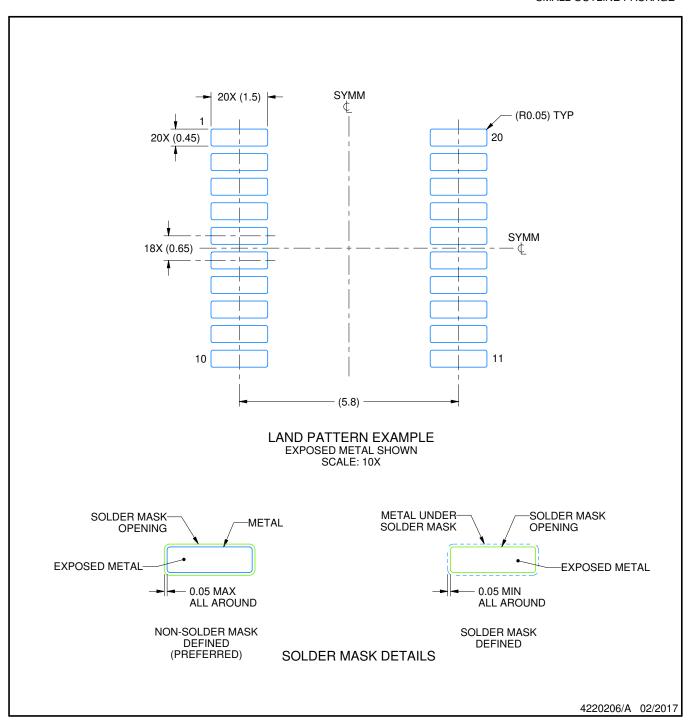


- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.

  2. This drawing is subject to change without notice.

  3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not
- exceed 0.15 mm per side.
- 4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.25 mm per side.
- 5. Reference JEDEC registration MO-153.



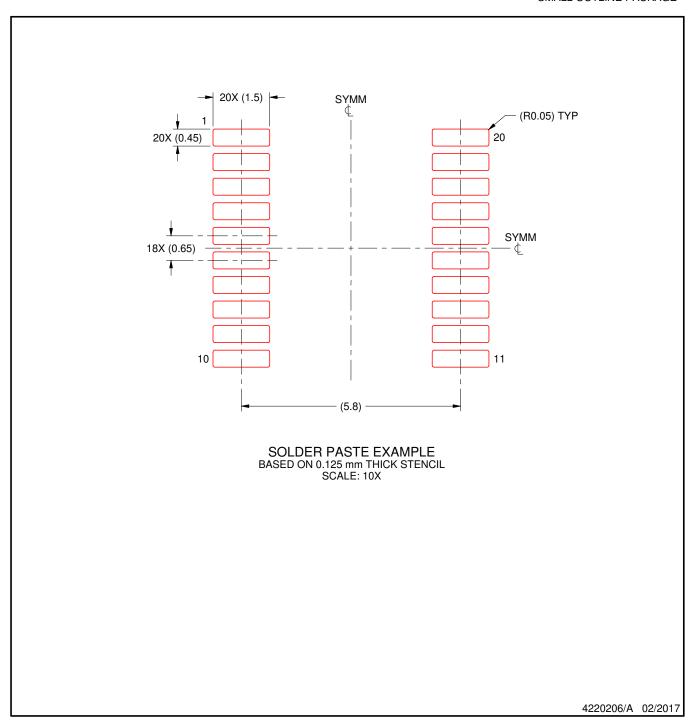


NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.





NOTES: (continued)

- 8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 9. Board assembly site may have different recommendations for stencil design.



# PW (R-PDSO-G20)

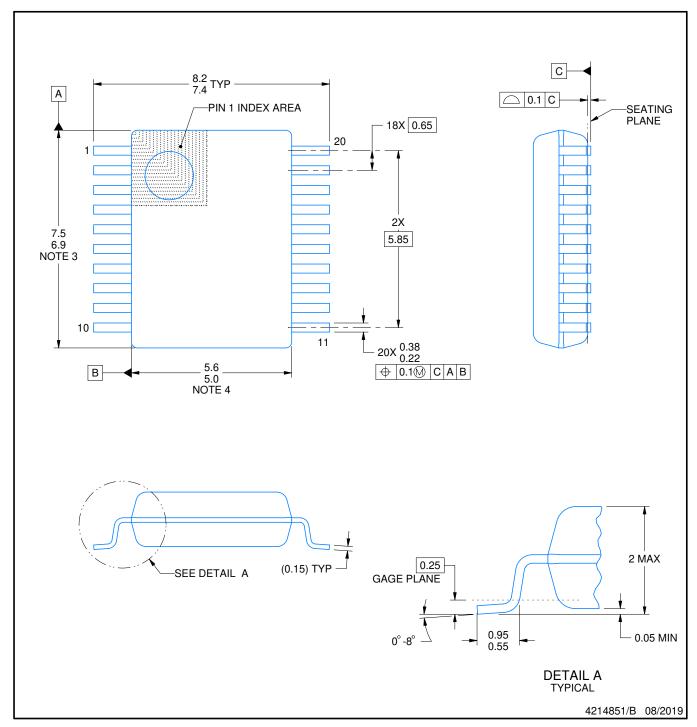
# PLASTIC SMALL OUTLINE



- All linear dimensions are in millimeters.
- B. This drawing is subject to change without notice.
  C. Publication IPC-7351 is recommended for alternate design.
- D. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC-7525 for other stencil recommendations.
- E. Customers should contact their board fabrication site for solder mask tolerances between and around signal pads.





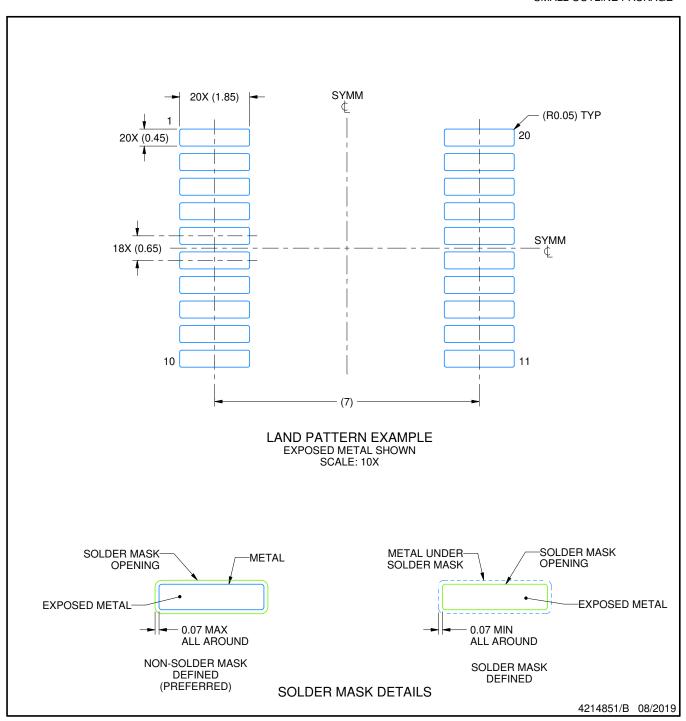


- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.

  2. This drawing is subject to change without notice.

  3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not
- exceed 0.15 mm per side.
- 4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.25 mm per side.
- 5. Reference JEDEC registration MO-150.



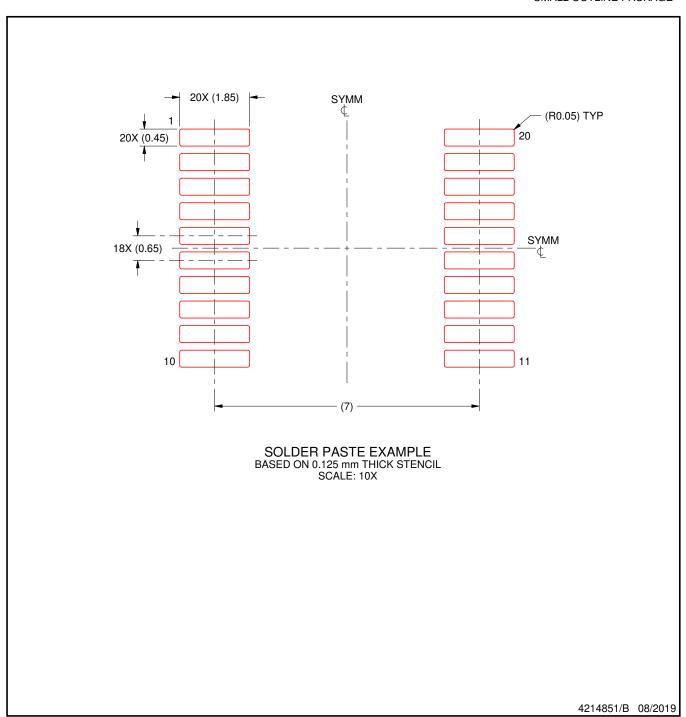


NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.





NOTES: (continued)

- 8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 9. Board assembly site may have different recommendations for stencil design.



# **MECHANICAL DATA**

# NS (R-PDSO-G\*\*)

# 14-PINS SHOWN

# PLASTIC SMALL-OUTLINE PACKAGE



- A. All linear dimensions are in millimeters.
- B. This drawing is subject to change without notice.
- C. Body dimensions do not include mold flash or protrusion, not to exceed 0,15.



# 14 LEADS SHOWN

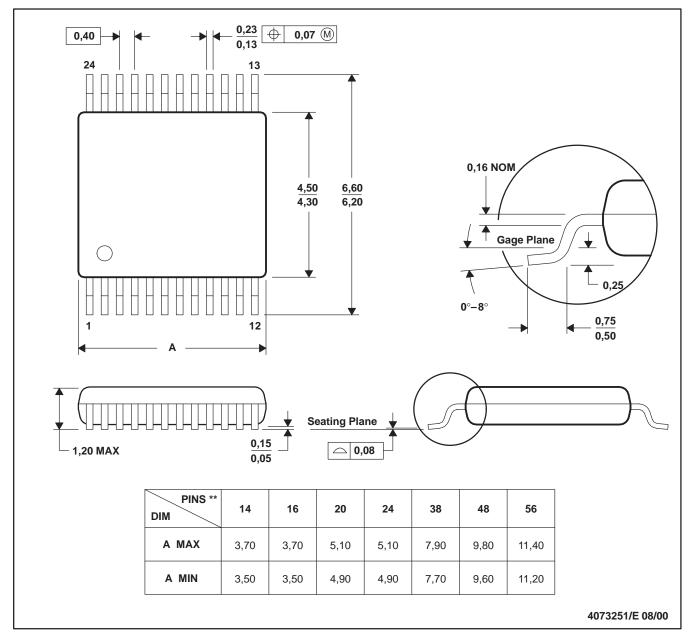


- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- C. This package is hermetically sealed with a ceramic lid using glass frit.
- D. Index point is provided on cap for terminal identification only on press ceramic glass frit seal only.
- E. Falls within MIL STD 1835 GDIP1-T14, GDIP1-T16, GDIP1-T18 and GDIP1-T20.

# DGV (R-PDSO-G\*\*)

#### 24 PINS SHOWN

#### **PLASTIC SMALL-OUTLINE**



NOTES: A. All linear dimensions are in millimeters.

B. This drawing is subject to change without notice.

C. Body dimensions do not include mold flash or protrusion, not to exceed 0,15 per side.

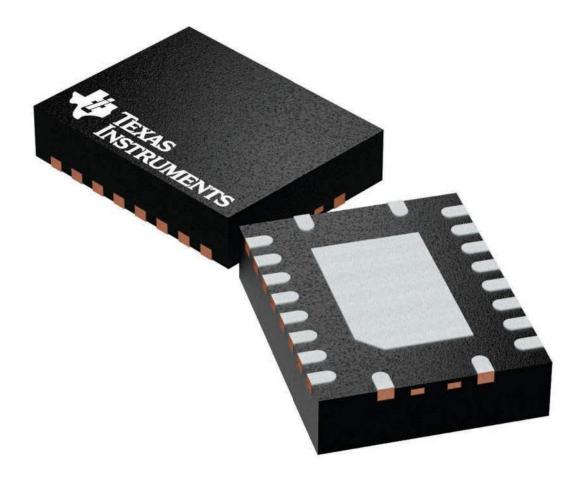
D. Falls within JEDEC: 24/48 Pins – MO-153 14/16/20/56 Pins – MO-194



3.5 x 4.5, 0.5 mm pitch

PLASTIC QUAD FGLATPACK - NO LEAD

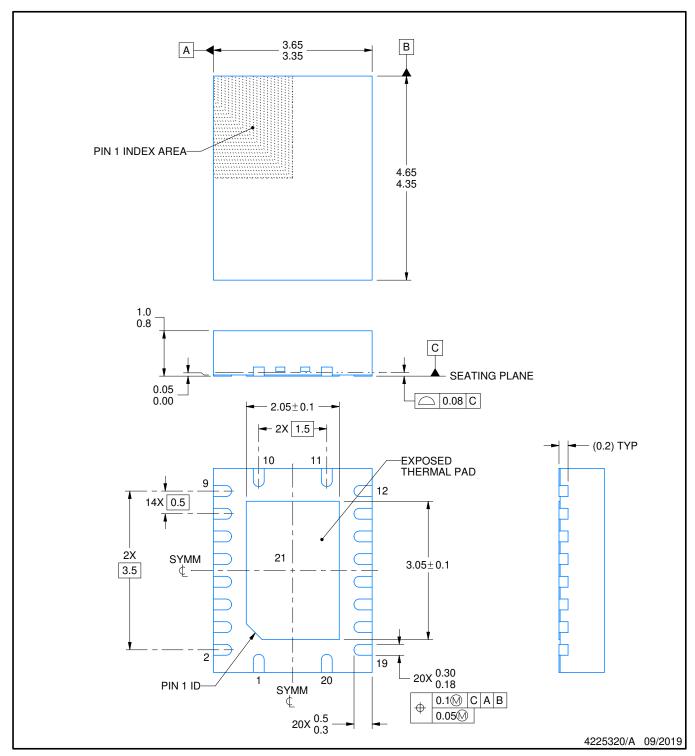
This image is a representation of the package family, actual package may vary. Refer to the product data sheet for package details.



**INSTRUMENTS** www.ti.com



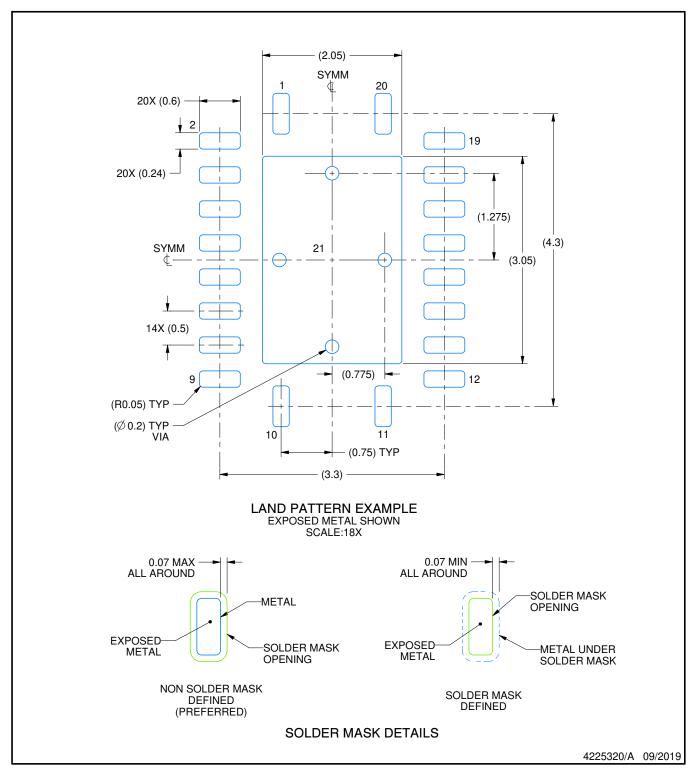
PLASTIC QUAD FLATPACK - NO LEAD



- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
  2. This drawing is subject to change without notice.
- 3. The package thermal pad must be soldered to the printed circuit board for thermal and mechanical performance.



PLASTIC QUAD FLATPACK - NO LEAD

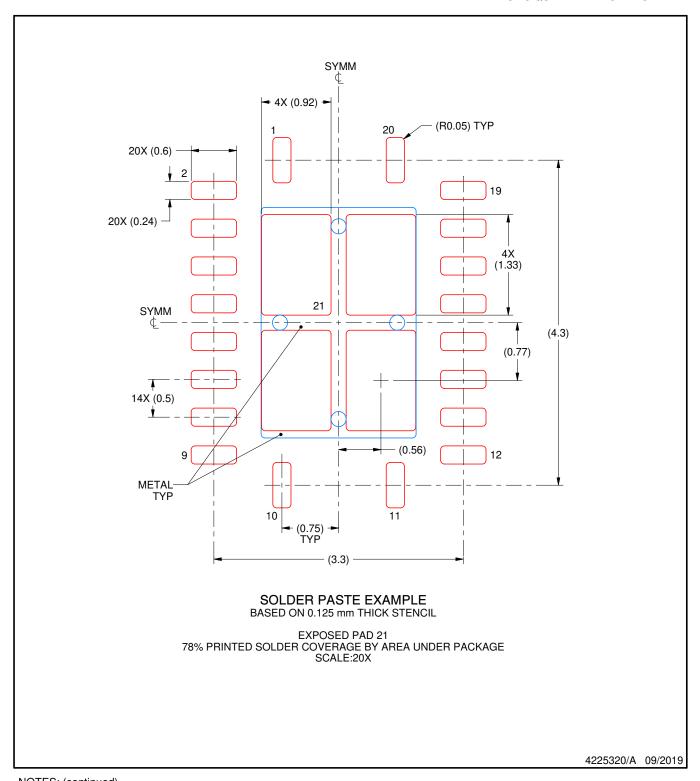


NOTES: (continued)

- 4. This package is designed to be soldered to a thermal pad on the board. For more information, see Texas Instruments literature number SLUA271 (www.ti.com/lit/slua271).
- Vias are optional depending on application, refer to device data sheet. If any vias are implemented, refer to their locations shown on this view. It is recommended that vias under paste be filled, plugged or tented.



PLASTIC QUAD FLATPACK - NO LEAD



NOTES: (continued)

6. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.



8.89 x 8.89, 1.27 mm pitch

LEADLESS CERAMIC CHIP CARRIER

This image is a representation of the package family, actual package may vary. Refer to the product data sheet for package details.



# N (R-PDIP-T\*\*)

# PLASTIC DUAL-IN-LINE PACKAGE

16 PINS SHOWN



- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- Falls within JEDEC MS-001, except 18 and 20 pin minimum body length (Dim A).
- The 20 pin end lead shoulder width is a vendor option, either half or full width.





SOIC



- 1. All linear dimensions are in millimeters. Dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.

  2. This drawing is subject to change without notice.

  3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not
- exceed 0.15 mm per side.
- 4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.43 mm per side.
- 5. Reference JEDEC registration MS-013.



SOIC



NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.



SOIC



NOTES: (continued)

- 8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 9. Board assembly site may have different recommendations for stencil design.



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